

INTERNATIONAL STANDARD



**High frequency inductive components – Non-electrical characteristics and measuring methods –
Part 2: Test methods for non-electrical characteristics**

Document Preview

[IEC 62025-2:2019](#)

<https://standards.iteh.ai/catalog/standards/iec/719dca20-a788-4d47-9566-5f7c50cdf3fd/iec-62025-2-2019>



THIS PUBLICATION IS COPYRIGHT PROTECTED

Copyright © 2019 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

IEC publications search - webstore.iec.ch/advsearchform

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee,...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: sales@iec.ch.

Electropedia - www.electropedia.org

The world's leading online dictionary on electrotechnology, containing more than 22 000 terminological entries in English and French, with equivalent terms in 16 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

IEC Glossary - std.iec.ch/glossary

67 000 electrotechnical terminology entries in English and French extracted from the Terms and Definitions clause of IEC publications issued since 2002. Some entries have been collected from earlier publications of IEC TC 37, 77, 86 and CISPR.

[IEC 62025-2:2019](http://standards.iteh.ai/catalog/standards/iec/719dca20-a788-4d47-9566-5f7c50cdf3fd/iec-62025-2-2019)

<https://standards.iteh.ai/catalog/standards/iec/719dca20-a788-4d47-9566-5f7c50cdf3fd/iec-62025-2-2019>



IEC 62025-2

Edition 2.0 2019-09
REDLINE VERSION

INTERNATIONAL STANDARD



**High frequency inductive components – Non-electrical characteristics and measuring methods –
Part 2: Test methods for non-electrical characteristics**

Document Preview

[IEC 62025-2:2019](https://standards.iteh.ai/catalog/standards/iec/719dca20-a788-4d47-9566-5f7c50cdf3fd/iec-62025-2-2019)

<https://standards.iteh.ai/catalog/standards/iec/719dca20-a788-4d47-9566-5f7c50cdf3fd/iec-62025-2-2019>

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

ICS 29.100.10

ISBN 978-2-8322-7432-3

Warning! Make sure that you obtained this publication from an authorized distributor.

CONTENTS

FOREWORD	4
1 Scope	6
2 Normative references	6
3 Terms and definitions	7
4 Test conditions	7
4.1 Standard atmospheric conditions for test	7
4.2 Referee conditions	7
5 Mechanical characteristics test	8
5.1 Body strength test	8
5.1.1 Body strength test procedures	8
5.1.2 Information to be given in the detail specification	9
5.2 Robustness of terminations (electrodes)	9
5.2.1 Resistance to bending of printed-circuit board	9
5.2.2 Adherence test (see test of Ue ₃ of IEC 60068-2-21)	13
5.3 Solderability	15
5.3.1 General	15
5.3.2 Preconditioning	15
5.3.3 Initial measurement	15
5.3.4 Test method	15
5.3.5 Recovery	17
5.3.6 Final measurement	17
5.3.7 Items to be specified in detail specification	17
5.4 Resistance to soldering heat	18
5.4.1 General	18
5.4.2 Preconditioning	18
5.4.3 Initial measurement	18
5.4.4 Test method	18
5.4.5 Recovery	19
5.4.6 Final measurement	19
5.4.7 Items to be specified in detail specification	19
5.5 Resistance to dissolution of metallization	20
5.5.1 General	20
5.5.2 Preconditioning	20
5.5.3 Initial measurement	20
5.5.4 Test methods	20
5.5.5 Final measurements	20
5.5.6 Items to be specified in detail specification	21
5.6 Vibration	21
5.6.1 Test equipment	21
5.6.2 Preparation	21
5.6.3 Test method	21
5.6.4 Items to be specified in detail specification	21
5.7 Resistance to shock	22
5.7.1 Mechanical shock method	22
5.7.2 Items to be specified in detail specification	22

Annex A (normative) Mounting of surface mounting inductor on test printed-circuit board	23
A.1 General.....	23
A.2 Mounting printed-circuit board and mounting land	23
A.3 Solder.....	23
A.4 Preparation	24
A.5 Preheating	24
A.6 Soldering	24
A.7 Cleaning	24
Figure 1 – Method for pressurizing the body	8
Figure 2 – Pressurizing jig	9
Figure 3 – Example of printed-circuit board.....	10
Figure 4 – Layout.....	12
Figure 5 – Pressurizing jig	12
Figure 6 – Pressurizing	12
Figure 7 – Pressurizing and shape of jig	14
Figure 8 – Reflow temperature profile	17
Table 1 – Size of soldering lands according to the code of multi-layer chip inductors.....	10
Table 2 – Thickness of solder paste by the size code of inductors	11
Table 3 – Conditions of immersion into solder.....	16
Table 4 – Reflow temperature.....	16
Table 5 – Severity.....	18
Table 6 – Reflow temperature	19
Table 7 – Conditions of vibration.....	21

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**HIGH FREQUENCY INDUCTIVE COMPONENTS –
NON-ELECTRICAL CHARACTERISTICS AND MEASURING METHODS –****Part 2: Test methods for non-electrical characteristics**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

This redline version of the official IEC Standard allows the user to identify the changes made to the previous edition. A vertical bar appears in the margin wherever a change has been made. Additions are in green text, deletions are in strikethrough red text.

International Standard IEC 62025-2 has been prepared by IEC technical committee 51: Magnetic components, ferrite and magnetic powder materials.

This second edition cancels and replaces the first edition published in 2005. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) revision of Table 5;
- b) revision of normative references.

The text of this standard is based on the following documents:

CDV	Report on voting
51/1273/CDV	51/1301/RVC

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62025 series, published under the general title *High frequency inductive components – Non-electrical characteristics and measuring methods*, can be found on the IEC website.

(<https://standards.iteh.ai>)

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed;

[IEC 62025-2:2019](#)

<http://standards.iteh.ai/catalog/standards/iec/719dca20-a788-4d47-9566-5f7c50cdf3fd/iec-62025-2-2019>

- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

HIGH FREQUENCY INDUCTIVE COMPONENTS – NON-ELECTRICAL CHARACTERISTICS AND MEASURING METHODS –

Part 2: Test methods for non-electrical characteristics

1 Scope

This part of IEC 62025 specifies a test method for the non-electrical characteristics of the surface mounted device (SMD) inductors to be used for electronic and telecommunication equipment. The object of this part of this document is to define methods for measuring mechanical performance only. As the reliability performances and specifications relative to non-electrical performances are defined in IEC 62211, detailed measuring methods for mechanical performance of reliability testing are defined in this document.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-1:~~1988~~, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-6:~~1995~~2007, *Environmental testing – Part 2: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-20:~~1979~~, *Environmental testing – Part 2-20: Tests – Test T: ~~Soldering~~ Test methods for solderability and resistance to soldering heat of devices with leads*

IEC 60068-2-21:~~1999~~2006, *Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices*

IEC 60068-2-27:~~1987~~, *Environmental testing – Part 2-27: Tests – Test Ea and guidance: Shock*

IEC 60068-2-45:1980, *Basic environmental testing procedures – Part 2-45: Tests – Test XA and guidance: Immersion in cleaning solvents*
IEC 60068-2-45:1980/AMD1:1993

IEC 60068-2-58:~~2004~~2015, *Environmental testing – Part 2-58: Tests – Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)*
IEC 60068-2-58:2015/AMD1:2017

IEC 60068-2-69, *Environmental testing – Part 2-69: Tests – Test Te/Tc: Solderability testing of electronic components ~~for surface mount technology~~ and printed boards by the wetting balance (force measurement) method*

IEC 60068-2-77:~~1999~~, *Environmental testing – Part 2-77: Tests – Test 77: Body strength and impact shock*

IEC 61188-5-2:~~2003~~, *Printed boards and printed board assemblies – Design and use – Part 5-2: Attachment (land/joint) considerations – Discrete components*

IEC 61190-1-2:~~2002~~2014, *Attachment materials for electronic assembly – Part 1-2: Requirements for soldering pastes for high-quality interconnections in electronics assembly*

IEC 61190-1-3:~~2002~~, *Attachment materials for electronic assembly – Part 1-3: Requirements for electronic grade solder alloys and fluxed and non-fluxed solid solder for electronic soldering applications*

IEC 62211:~~2003~~2017, *Inductive components – Reliability management*

3 Terms and definitions

~~For the purpose of this part of IEC 62025, the terms and definitions given in the normative references apply.~~

No terms and definitions are listed in this document.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

4 Test conditions

4.1 Standard atmospheric conditions for test

Unless otherwise specified in the detail specification, the tests and measurements shall be carried out under the standard atmospheric conditions for test as given in ~~5.3.1~~ the requirements for standard reference atmosphere of IEC 60068-1:

- temperature: 15 °C to 35 °C; [IEC 62025-2:2019](http://standards.iteh.ai/catalog/standards/iec/719dca20-a788-4d47-9566-517c50cd3fd/iec-62025-2-2019)
- relative humidity: 25 % to 75 %;
- air pressure: 86 kPa to 106 kPa.

In the event of dispute or where required, the measurements shall be repeated using the referee temperatures (as given in 4.2) and such other conditions as are ~~prescribed~~ specified in this document.

In addition, when it is difficult to make measurements in standard atmospheric conditions, unless a doubt arises about the validity of the result, the tests and measurements may be performed in non-standard atmospheric conditions.

4.2 Referee conditions

For referee purposes, one of the standard atmospheric conditions for referee tests taken from ~~5.2~~ the requirements for standard atmospheres for referee measurements and tests of IEC 60068-1, shall be selected and shall be as follows:

- temperature: 20 °C ± 2 °C;
- relative humidity: 60 % to 70 %;
- air pressure: 86 kPa to 106 kPa.

5 Mechanical characteristics test

5.1 Body strength test

5.1.1 Body strength test procedures

The body strength test procedure, as ~~referenced~~ specified in IEC 60068-2-77, shall be as follows:

a) Preconditioning

If required, preconditioning shall be performed on the specimens in accordance with the detail specification.

b) Initial measurement

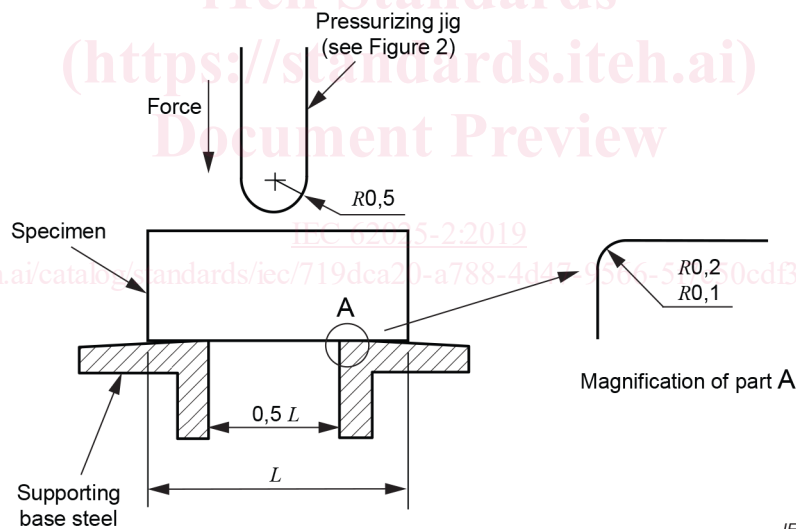
The appearance of the specimen shall be checked with a magnification of at least 10× under adequate light.

If specified in the detail specification, the electrical performances shall be measured.

c) Layout

Unless otherwise specified in the detail specification, the specimen shall be placed on the supporting base, as shown in Figure 1, so that both ends of the specimen are symmetrically positioned on the supporting base. The test table shall be placed on a plane, robust platform so that the test result ~~shall~~ is not ~~be~~ affected when a force is applied.

Dimensions en millimètres



IEC

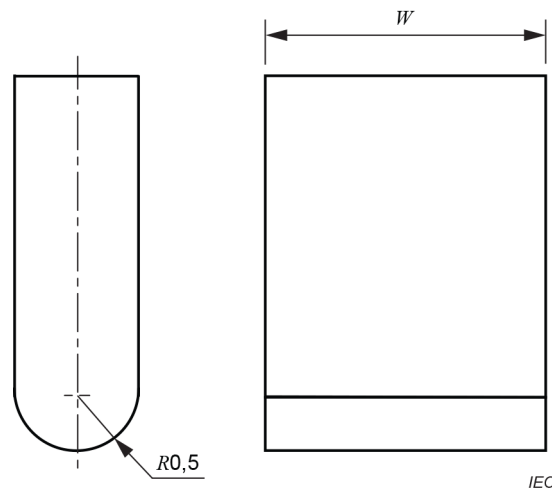
NOTE The angle of the taper in part A shall be between 70° and 90°.

Figure 1 – Method for pressurizing the body

d) Applied force

The force shall be applied to the centre of the specimen by the pressurizing jig as shown in Figure 2, for a duration of (10 ± 1) s. Unless otherwise specified in the detail specification, the force shall be selected from either (one of) 10 N, 20 N or 30 N. If specified in the detail specification, the electrical performances shall be measured during the application of the force.

Dimensions in millimetres



NOTE 1 Dimension W of the pressurizing jig is wider than the width of the specimen.

NOTE 2 Hardness: HV 500 and more.

NOTE 3 When the length of the specimen is 2 mm or less, the radius of the pressurizing jig should be 0,2 mm.

Figure 2 – Pressurizing jig

e) Recovery

If required, recovery conditioning shall be performed for the specimens in accordance with the detail specification.

f) Final measurement

After the test, the appearance of the specimen shall be checked with a magnification of at least 10× under adequate light. There shall be no signs of damage such as cracks or flaws. If specified in the detail specification, the electrical performances shall be measured.

5.1.2 Information to be given in the detail specification

The following information shall be given in the detail specification:

- a) preconditioning (if required) – see 5.1.1.a);
- b) initial measurement items, final measurement items (if required) – see 5.1.1.b) and f);
- c) measurement during applied force (if required) – see 5.1.1.d);
- d) recovery (if required) – see 5.1.1.e).

5.2 Robustness of terminations (electrodes)

5.2.1 Resistance to bending of printed-circuit board

5.2.1.1 General

The test for the resistance of terminations and electrodes mounted on a printed-circuit board shall be as follows.

5.2.1.2 Specification of soldering lands

The soldering lands of multi-layer chip inductors shall be designed according to Table 1, as specified in ~~11.5 of~~ IEC 61188-5-2. With regard to inductors, except for those specified in IEC 61188-5-2, the size of the solder lands shall be specified in the detail specification.

Table 1 – Size of soldering lands by according to the code of multi-layer chip inductors

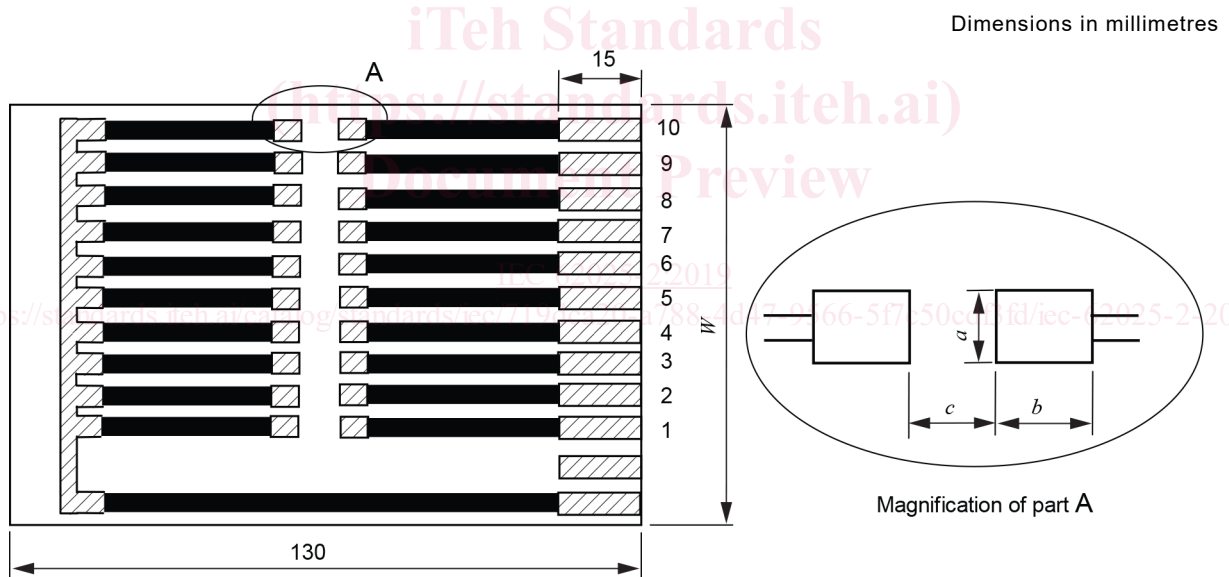
Dimensions in millimetres

Size code	<i>a</i>	<i>b</i>	<i>c</i>
1005	0,65	0,55	0,50
1608	0,95	0,85	0,50
2012	1,45	1,10	0,50
3216	1,80	1,30	1,20
3225	2,70	1,05	1,80
4532	3,40	1,10	3,00
5650	5,30	1,30	3,70

NOTE Tolerance: 0,05 mm; see Figure 3.

5.2.1.3 Specification of printed-circuit board

The printed-circuit board shall be made of epoxide woven glass (FR4) as specified in IEC 60068-2-21, and, unless specified in the detail specification, the printed-circuit board shall be as shown in Figure 3. The dimension of *W* shall be specified in the detail specification.



Key

- solderable areas
- non-solderable areas (covered with non-solderable lacquer)

Materials of substrate: epoxide woven glass (FR4)

Thickness: 1,6 mm ± 0,2 mm (for size code from 1608)

Thickness: 0,8 mm ± 0,1 mm (for size code up to 1005)

Conductors: copper

Thickness: 0,035 mm ± 0,010 mm

NOTE When the board is designed to mount more than two specimens, allow sufficient space between specimens so as not to influence the test result. Dimensions not given shall be chosen according to the design and size of the specimen to be tested.

Figure 3 – Example of printed-circuit board

5.2.1.4 Mounting of specimen

The specimen shall be mounted on the printed-circuit board in accordance with Annex A and other specifications as mentioned below.

- a) The solder paste shall be placed on the soldering lands. The applied solder paste shall cover the soldering lands completely. The thickness of the solder paste ~~by~~ according to the size code of inductors is recommended in Table 2. The appropriate height of the fillet should be the smaller value of either 50 % of the thickness of the specimen or 0,5 mm.

Table 2 – Thickness of solder paste by the size code of inductors

Size code	Thickness of solder paste μm
Up to 1608	100 to 150
From 2012	150 to 200

- b) The specimen shall then be placed on the printed-circuit board. The terminations of the specimen shall be placed on the soldering lands symmetrically in both horizontal and vertical directions.
- c) The printed-circuit board with the specimen shall be reflow soldered. Care shall be taken when mounting the inductor on the printed-circuit board so that warp or twist does not occur.
- d) If specified in the detail specification, the printed-circuit board shall be cleaned according to Annex A.

5.2.1.5 Preconditioning

Preconditioning shall be carried out as specified in the detail specification when preconditioning is necessary.

5.2.1.6 Initial measurement

Prior to conducting the mechanical test, the appearance of the specimen and the soldered parts shall be checked by using a magnifier with a magnification of at least 10× under adequate light. If an abnormal or rejectable appearance is found, the specimen shall be excluded from the evaluation on this test. The electrical performances shall be measured if specified in the detail specification.

5.2.1.7 Bending tool

The bending tool shall be a support jig as shown in Figure 4 and a pressurizing jig as shown in Figure 5. The radius of the pressurizing jig should be 5 mm. If specified in the detail specification, the radius of the pressurizing jig may be 340 mm or 230 mm.

5.2.1.8 Layout

The printed-circuit board with the soldered specimen is placed on the support jig as shown in Figure 4.

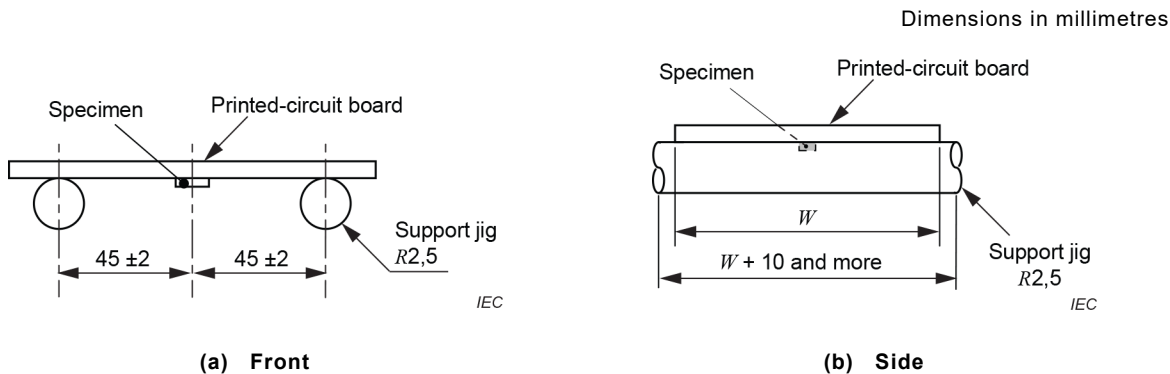
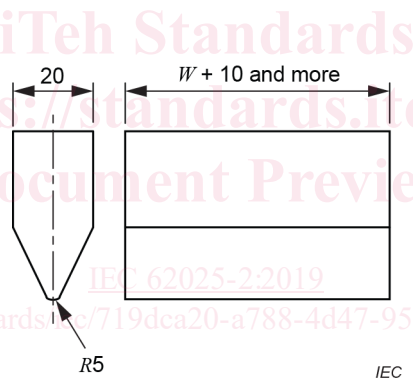


Figure 4 – Layout

5.2.1.9 Test

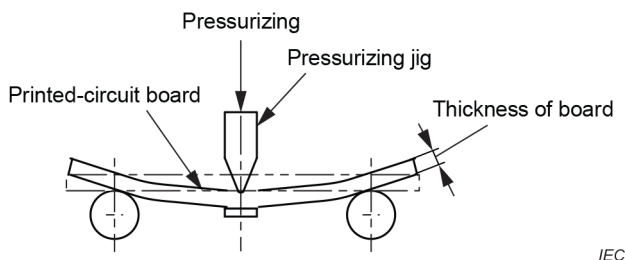
The printed-circuit board shall be bent by using the pressurizing jig as shown in Figure 5 at a rate of $(1 \pm 0,5)$ mm/s and to the bending depth of 1 mm, 2 mm, 3 mm or 4 mm (see Figure 6). The bending depth shall be specified in the detail specification. After reaching the specified bending depth, it shall be maintained for (20 ± 1) s. Then the bending force shall be relaxed. Unless specified in the detail specification, the number of bends shall be one.



Key

R radius

Figure 5 – Pressurizing jig



NOTE The relative position between the centre of the specimen on the soldering land of the printed-circuit board and the contact-line of the pressurizing jig on the printed-circuit board ~~should~~ does not exceed 0,5 mm.

Figure 6 – Pressurizing